Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | LOOK, CHRISTOPHER M. | Examiner | Art Unit | Wai Lun Leung | 2613 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,307,653 B1	10-2001	Bala et al.	398/2
*	В	US-6,477,288 B1	11-2002	Sato, Kouki	385/16
*	С	US-6,556,319 B2	04-2003	Feinberg et al.	398/5
*	۵	US-6,898,376 B1	05-2005	Gerstel et al.	398/5
*	Е	US-6,771,908 B2	08-2004	Eijk et al.	398/66
*	F	US-6,433,900 B1	08-2002	Kuroyanagi et al.	398/19
	G	US-			
	н	US-			
	_	US-			
	7	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	o	,				
	Р				,	
	Q					
	R					,
	s					
	Т					

NON-PATENT DOCUMENTS

	NON-PATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	V						
•	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.